



IMSE-CNM



INSTITUTO DE MICROELECTRÓNICA DE SEVILLA

KEYSIGHT TECHNOLOGIES SEMINARS



High Speed Digital Measurement Insights

The continued increase in consumers using more data drives a wider adoption of high speed digital signals in electronic products, which increases the complexity of your design, including how to test and debug your product. Making the right decisions early in the process will enable you to avoid prototype re-spins and bring your product to market before the competition.

Keysight's High Speed Digital Insights Hotspots Seminar addresses the challenges facing designers and developers at component, circuit and system levels.

Full Day Agenda:

- 09:00 Welcome and Opening.
- 09:20 High Speed Digital Fundamentals.
- 11:00 Café.
- 11:30 Advanced Jitter Measurements.
- 12:30 Crosstalk Analyses.
- 13:30 Finish.

Places are limited.

Registration is free at:

contactcenter_spain@keysight.com || [web](#) || Phone: 800 000 154

Instituto de Microelectrónica de Sevilla IMSE-CNM
November 29, 2018

ABOUT IMSE

- Introduction
- How to find us
- Organization
- Staff
- Visiting IMSE

RESOURCES

- Laboratories
- IT
- CAD tools

RESEARCH

- Research Units
- Projects
- Catalog of ICs
- Patents

PUBLICATIONS

- IMSE publications
- Library

JOB & TRAINING

- Education at IMSE
- Career at IMSE
- Career at Universidad de Sevilla
- Career at CSIC



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